 Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/068,278	CHANG ET AL.	
Examiner	Art Unit	
Cheukfan Lee	2622	

SEARCHED			
Class	Subclass	Date	Examiner
358	512-514	10/7/2005	C.L.
	482,483		
	523,444		
	505,506		
	509		
	487,474		
	494,497		
250	208.1		
	234-236		
348	311		
	317		
	714		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			
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SEARCH NO (INCLUDING SEARCH	TES I STRATEGY)
	DATE	EXMR
EAST search: see result	10/7/2005	C.L.
Inventor search		